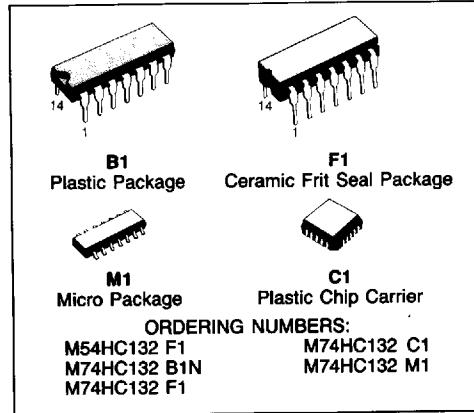
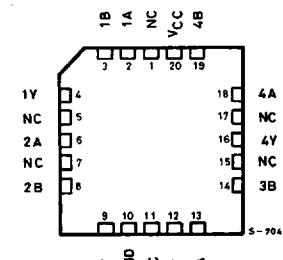
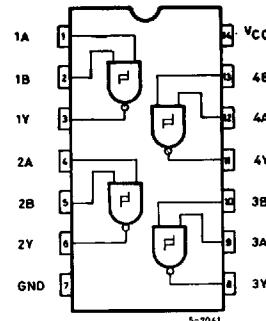




S G S-THOMSON

M54HC132
M74HC132
T-43-21**QUAD 2-INPUT SCHMITT NAND GATE**

- HIGH SPEED
 $t_{PD} = 21 \text{ ns (TYP.)}$ at $V_{CC} = 5 \text{ V}$
- LOW POWER DISSIPATION
 $I_{CC} = 1 \mu\text{A (MAX.)}$ at $T_A = 25^\circ\text{C}$
- OUTPUT DRIVE CAPABILITY
10 LSTTL LOADS
- HIGH NOISE IMMUNITY
 $V_H (\text{TYP.}) = 0.9 \text{ V}$ at $V_{CC} = 5 \text{ V}$
- BALANCED PROPAGATION DELAYS
 $t_{PLH} = t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE
 $V_{CC} (\text{OPR}) = 2 \text{ V to } 6 \text{ V}$
- PIN AND FUNCTION COMPATIBLE
WITH 54/74LS132

**PIN CONNECTIONS (top view)**

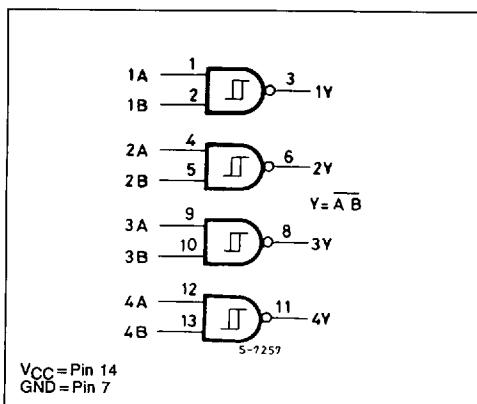
NC =
No Internal
Connection

DESCRIPTION

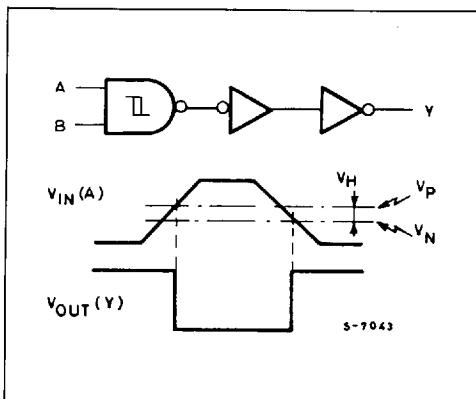
The M54/74HC132 is a high speed CMOS QUAD 2-INPUT SCHMITT NAND GATE fabricated in silicon gate C²MOS technology. It has the same high speed performance of LSTTL combined with true CMOS low power consumption. Pin configuration and function are identical to those of the M54/74HC00.

The hysteresis characteristics (around 20% V_{CC}) of all inputs allow slowly changing input signals to be transformed into sharply defined jitter-free output signals. All inputs are equipped with protection circuits against static discharge and transient excess voltage.

BLOCK DIAGRAM



LOGIC DIAGRAM/WAVEFORM



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ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	-0.5 to 7	V
V_I	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
V_O	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
I_{IK}	DC Input Diode Current	± 20	mA
I_{OK}	DC Output Diode Current	± 20	mA
I_O	DC Output current per pin	± 25	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	± 50	mA
P_D	Power Dissipation	500 (*)	mW
T_{stg}	Storage Temperature	-65 to 150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(*) 500 mW = derate to 10 mW/°C from 65°C to 85°C for plastic package

(*) 500 mW = derate to 12 mW/°C from 100 to 125°C for frit-seal package

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	2 to 6	V
V_I	DC Input Voltage	0 to V_{CC}	V
V_O	DC Output Voltage	0 to V_{CC}	V
T_A	Operating Temperature 74HC Series 54HC Series	-40 to 85 -55 to 125	°C
t_r/t_f	Input Rise fall times	NO LIMITS	ns

DC SPECIFICATIONS

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Symbol	Parameter	V _{CC}	Test Condition	T _A =25°C 54HC and 74HC			-40 to 85°C 74HC		-55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
V _P	High Level Threshold Voltage	2.0 4.5 6.0		0.8 2.25 3.0	1.25 2.7 3.6	1.5 3.15 4.2	0.8 2.25 3.0	1.5 3.15 4.2	0.8 2.25 3.0	1.5 3.15 4.2	— V
V _N	Low Level Threshold Voltage	2.0 4.5 6.0		0.4 1.35 1.8	0.75 1.9 2.6	1.0 2.25 3.0	0.4 1.35 1.8	1.0 2.25 3.0	0.4 1.35 1.8	1.0 2.25 3.0	V
V _H	Hysteresis Voltage	2.0 4.5 6.0		0.20 0.4 0.6	0.5 0.8 1.0	1.0 1.4 1.7	0.20 0.4 0.6	1.0 1.4 1.7	0.20 0.4 0.6	1.0 1.4 1.7	V
V _{OH}	High Level Output Voltage	2.0	V _I	I _O	1.9	2.0	—	1.9	—	1.9	—
		4.5	V _{IH} or V _{IL}	-20 μA	4.4	4.5	—	4.4	—	4.4	—
		6.0		5.9	6.0	—	5.9	—	5.9	—	V
		4.5 6.0	V _{IH} or V _{IL}	-4.0 mA -5.2 mA	4.18 5.68	4.31 5.8	—	4.13 5.63	—	4.10 5.60	—
V _{OL}	Low Level Output Voltage	2.0 4.5 6.0		20 μA	— — —	0.0 0.0 0.0	0.1 0.1 0.1	— — —	0.1 0.1 0.1	— — —	V
		4.5 6.0	V _{IH} or V _{IL}	4.0 mA 5.2 mA	— —	0.17 0.18	0.26 0.26	— —	0.33 0.33	— —	0.40 0.40
		6.0									
I _I	Input Leakage Current	6.0	V _I =V _{CC} or GND		—	—	±0.1	—	±1.0	—	±1.0 μA
I _{CC}	Quiescent Supply Current	6.0	V _I =V _{CC} or GND		—	—	1	—	10	—	20 μA

AC ELECTRICAL CHARACTERISTICS (V_{CC}=5V, T_A=25°C, C_L=15pF, Input t_r=t_f=6ns)

Symbol	Parameter	54HC and 74HC			Unit
		Min.	Typ.	Max.	
t _{TLH} t _{THL}	Output Transition Time		4	8	ns
t _{PLH} t _{PHL}	Propagation Delay Time		13	21	ns

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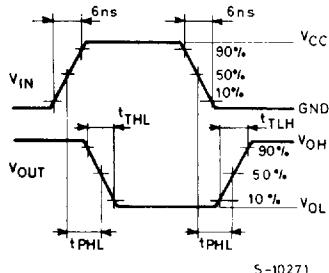
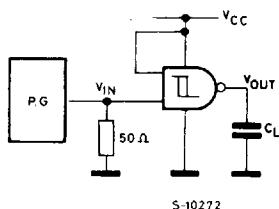
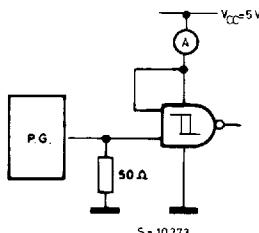
AC ELECTRICAL CHARACTERISTICS ($C_L = 50\text{pF}$, Input $t_r = t_f = 6\text{ns}$)

Symbol	Parameter	V_{CC}	Test Condition	$T_A = 25^\circ\text{C}$ 54HC and 74HC			-40 to 85°C 74HC		-55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t_{TLH}	Output Transition Time	2.0		—	30	75	—	95	—	110	ns
t_{THL}		4.5		—	8	15	—	19	—	22	ns
		6.0		—	7	13	—	16	—	19	ns
t_{PLH}	Propagation Delay Time	2.0		—	64	125	—	155	—	190	ns
t_{PHL}		4.5		—	16	25	—	31	—	38	ns
		6.0		—	14	21	—	26	—	32	ns
C_{IN}	Input Capacitance			—	5	10	—	10	—	10	pF
CPD (*)	Power Dissipation Capacitance			—	34	—	—	—	—	—	pF

Note (*) CPD is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current is: $I_{CC} (\text{Opr.}) = CPD \cdot V_{CC} \cdot f_{IN} + I_{CC}/4$ (per gate)

SWITCHING CHARACTERISTICS TEST CIRCUIT

TEST CIRCUIT I_{CC} (Opr.)

INPUT WAVEFORM IS THE SAME AS THAT IN CASE OF SWITCHING CHARACTERISTICS TEST